

Docket No.: 2950.09US02 Application No.: 09/557,696

APPLICANT: BI et al.

FILING DATE: April 25, 2000

	III AII AII	CICATION	GROU	GROUP ART UNIT: 1743			
		U.	S. PATENT DOCU	MENTS			
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING I	
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.